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#### Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

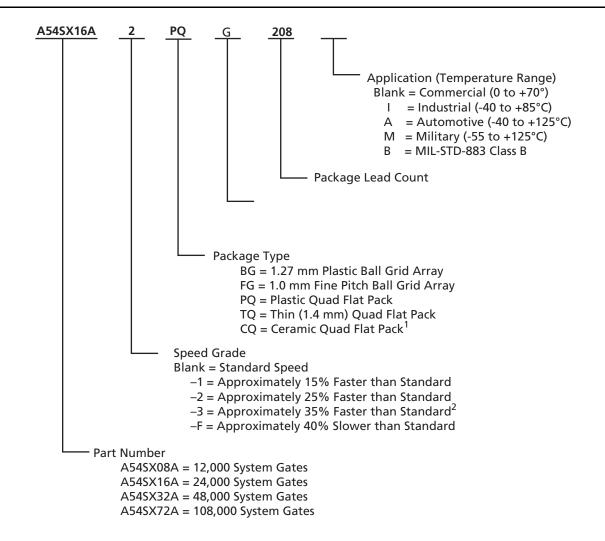
EXF

20140	
Product Status	Active
Number of LABs/CLBs	2880
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	81
Number of Gates	48000
Voltage - Supply	2.25V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	-55°C ~ 125°C (TC)
Package / Case	100-LQFP
Supplier Device Package	100-TQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/a54sx32a-1tqg100m

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

# **Ordering Information**



#### Notes:

1. For more information about the CQFP package options, refer to the HiRel SX-A datasheet.

2. All –3 speed grades have been discontinued.

# **Device Resources**

	User I/Os (Including Clock Buffers)											
Device	208-Pin PQFP	100-Pin TQFP	144-Pin TQFP	176-Pin TQFP	329-Pin PBGA	144-Pin FBGA	256-Pin FBGA	484-Pin FBGA				
A54SX08A	130	81	113	-	-	111	-	-				
A54SX16A	175	81	113	-	-	111	180	_				
A54SX32A	174	81	113	147	249	111	203	249				
A54SX72A	171	-	-	_	-	-	203	360				

**Notes:** Package Definitions: PQFP = Plastic Quad Flat Pack, TQFP = Thin Quad Flat Pack, PBGA = Plastic Ball Grid Array, FBGA = Fine Pitch Ball Grid Array

## Logic Module Design

The SX-A family architecture is described as a "sea-ofmodules" architecture because the entire floor of the device is covered with a grid of logic modules with virtually no chip area lost to interconnect elements or routing. The Actel SX-A family provides two types of logic modules: the register cell (R-cell) and the combinatorial cell (C-cell).

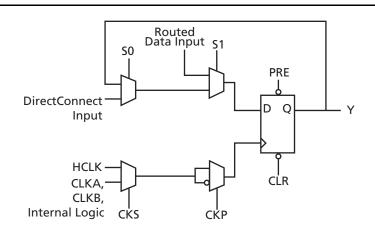
The R-cell contains a flip-flop featuring asynchronous clear, asynchronous preset, and clock enable, using the S0 and S1 lines control signals (Figure 1-2). The R-cell registers feature programmable clock polarity selectable on a register-by-register basis. This provides additional flexibility while allowing mapping of synthesized functions into the SX-A FPGA. The clock source for the R-cell can be chosen from either the hardwired clock, the routed clocks, or internal logic.

The C-cell implements a range of combinatorial functions of up to five inputs (Figure 1-3). Inclusion of the DB input and its associated inverter function allows up to 4,000 different combinatorial functions to be implemented in a single module. An example of the flexibility enabled by the inversion capability is the ability to integrate a 3-input exclusive-OR function into a single C-cell. This facilitates construction of 9-bit parity-tree functions with 1.9 ns propagation delays.

## **Module Organization**

All C-cell and R-cell logic modules are arranged into horizontal banks called Clusters. There are two types of Clusters: Type 1 contains two C-cells and one R-cell, while Type 2 contains one C-cell and two R-cells.

Clusters are grouped together into SuperClusters (Figure 1-4 on page 1-3). SuperCluster 1 is a two-wide grouping of Type 1 Clusters. SuperCluster 2 is a two-wide group containing one Type 1 Cluster and one Type 2 Cluster. SX-A devices feature more SuperCluster 1 modules than SuperCluster 2 modules because designers typically require significantly more combinatorial logic than flip-flops.



#### Figure 1-2 • R-Cell

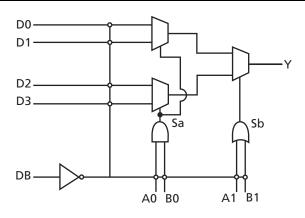


Figure 1-3 • C-Cell

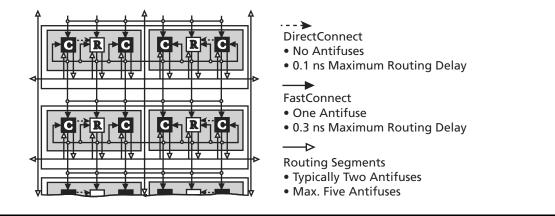


Figure 1-5 • DirectConnect and FastConnect for Type 1 SuperClusters

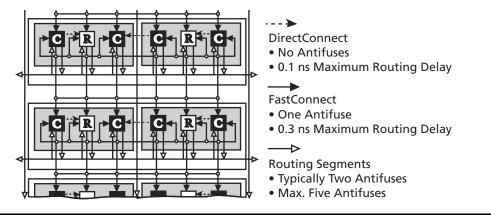


Figure 1-6 • DirectConnect and FastConnect for Type 2 SuperClusters

# **Related Documents**

## **Application Notes**

Global Clock Networks in Actel's Antifuse Devices http://www.actel.com/documents/GlobalClk\_AN.pdf Using A54SX72A and RT54SX72S Quadrant Clocks http://www.actel.com/documents/QCLK\_AN.pdf Implementation of Security in Actel Antifuse FPGAs http://www.actel.com/documents/Antifuse\_Security\_AN.pdf Actel eX, SX-A, and RTSX-S I/Os http://www.actel.com/documents/AntifuseIO\_AN.pdf Actel SX-A and RT54SX-S Devices in Hot-Swap and Cold-Sparing Applications http://www.actel.com/documents/HotSwapColdSparing\_AN.pdf Programming Antifuse Devices http://www.actel.com/documents/AntifuseProgram\_AN.pdf

## Datasheets

HiRel SX-A Family FPGAs http://www.actel.com/documents/HRSXA\_DS.pdf SX-A Automotive Family FPGAs http://www.actel.com/documents/SXA\_Auto\_DS.pdf

## **User's Guides**

Silicon Sculptor User's Guide http://www.actel.com/documents/SiliSculptII\_Sculpt3\_ug.pdf

# **Pin Description**

#### CLKA/B, I/O Clock A and B

These pins are clock inputs for clock distribution networks. Input levels are compatible with standard TTL, LVTTL, LVCMOS2, 3.3 V PCI, or 5 V PCI specifications. The clock input is buffered prior to clocking the R-cells. When not used, this pin must be tied Low or High (NOT left floating) on the board to avoid unwanted power consumption.

For A54SX72A, these pins can also be configured as user I/Os. When employed as user I/Os, these pins offer builtin programmable pull-up or pull-down resistors active during power-up only. When not used, these pins must be tied Low or High (NOT left floating).

#### QCLKA/B/C/D, I/O Quadrant Clock A, B, C, and D

These four pins are the quadrant clock inputs and are only used for A54SX72A with A, B, C, and D corresponding to bottom-left, bottom-right, top-left, and top-right quadrants, respectively. They are clock inputs for clock distribution networks. Input levels are compatible with standard TTL, LVTTL, LVCMOS2, 3.3 V PCI, or 5 V PCI specifications. Each of these clock inputs can drive up to a quarter of the chip, or they can be grouped together to drive multiple quadrants. The clock input is buffered prior to clocking the R-cells. When not used, these pins must be tied Low or High on the board (NOT left floating).

These pins can also be configured as user I/Os. When employed as user I/Os, these pins offer built-in programmable pull-up or pull-down resistors active during power-up only.

#### GND Ground

Low supply voltage.

#### HCLK Dedicated (Hardwired) Array Clock

This pin is the clock input for sequential modules. Input levels are compatible with standard TTL, LVTTL, LVCMOS2, 3.3 V PCI, or 5 V PCI specifications. This input is directly wired to each R-cell and offers clock speeds independent of the number of R-cells being driven. When not used, HCLK must be tied Low or High on the board (NOT left floating). When used, this pin should be held Low or High during power-up to avoid unwanted static power consumption.

#### I/O Input/Output

The I/O pin functions as an input, output, tristate, or bidirectional buffer. Based on certain configurations, input and output levels are compatible with standard TTL, LVTTL, LVCMOS2, 3.3 V PCI or 5 V PCI specifications. Unused I/O pins are automatically tristated by the Designer software.

#### NC No Connection

This pin is not connected to circuitry within the device and can be driven to any voltage or be left floating with no effect on the operation of the device.

#### PRA/B, I/O Probe A/B

The Probe pin is used to output data from any userdefined design node within the device. This independent diagnostic pin can be used in conjunction with the other probe pin to allow real-time diagnostic output of any signal path within the device. The Probe pin can be used as a user-defined I/O when verification has been completed. The pin's probe capabilities can be permanently disabled to protect programmed design confidentiality.

#### TCK, I/O Test Clock

Test clock input for diagnostic probe and device programming. In Flexible mode, TCK becomes active when the TMS pin is set Low (refer to Table 1-6 on page 1-9). This pin functions as an I/O when the boundary scan state machine reaches the "logic reset" state.

#### TDI, I/O Test Data Input

Serial input for boundary scan testing and diagnostic probe. In Flexible mode, TDI is active when the TMS pin is set Low (refer to Table 1-6 on page 1-9). This pin functions as an I/O when the boundary scan state machine reaches the "logic reset" state.

#### TDO, I/O Test Data Output

Serial output for boundary scan testing. In flexible mode, TDO is active when the TMS pin is set Low (refer to Table 1-6 on page 1-9). This pin functions as an I/O when the boundary scan state machine reaches the "logic reset" state. When Silicon Explorer II is being used, TDO will act as an output when the checksum command is run. It will return to user /IO when checksum is complete.

#### TMS Test Mode Select

The TMS pin controls the use of the IEEE 1149.1 Boundary Scan pins (TCK, TDI, TDO, TRST). In flexible mode when the TMS pin is set Low, the TCK, TDI, and TDO pins are boundary scan pins (refer to Table 1-6 on page 1-9). Once the boundary scan pins are in test mode, they will remain in that mode until the internal boundary scan state machine reaches the logic reset state. At this point, the boundary scan pins will be released and will function as regular I/O pins. The logic reset state is reached five TCK cycles after the TMS pin is set High. In dedicated test mode, TMS functions as specified in the IEEE 1149.1 specifications.

#### TRST, I/O Boundary Scan Reset Pin

Once it is configured as the JTAG Reset pin, the TRST pin functions as an active low input to asynchronously initialize or reset the boundary scan circuit. The TRST pin is equipped with an internal pull-up resistor. This pin functions as an I/O when the **Reserve JTAG Reset Pin** is not selected in Designer.

#### V<sub>CCI</sub> Supply Voltage

Supply voltage for I/Os. See Table 2-2 on page 2-1. All V<sub>CCI</sub> power pins in the device should be connected.

#### V<sub>CCA</sub> Supply Voltage

Supply voltage for array. See Table 2-2 on page 2-1. All  $V_{CCA}$  power pins in the device should be connected.

# **Detailed Specifications**

# **Operating Conditions**

#### Table 2-1 • Absolute Maximum Ratings

Symbol	Parameter	Limits	Units
V <sub>CCI</sub>	DC Supply Voltage for I/Os	-0.3 to +6.0	V
V <sub>CCA</sub>	DC Supply Voltage for Arrays	-0.3 to +3.0	V
VI	Input Voltage	-0.5 to +5.75	V
V <sub>O</sub>	Output Voltage	–0.5 to + V <sub>CCI</sub> + 0.5	V
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C

**Note:** \*Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the "Recommended Operating Conditions".

#### Table 2-2 Recommended Operating Conditions

Parameter	Commercial	Industrial	Units
Temperature Range	0 to +70	-40 to +85	°C
2.5 V Power Supply Range (V <sub>CCA</sub> and V <sub>CCI</sub> )	2.25 to 2.75	2.25 to 2.75	V
3.3 V Power Supply Range (V <sub>CCI</sub> )	3.0 to 3.6	3.0 to 3.6	V
5 V Power Supply Range (V <sub>CCI</sub> )	4.75 to 5.25	4.75 to 5.25	V

# **Typical SX-A Standby Current**

#### Table 2-3 • Typical Standby Current for SX-A at 25°C with $V_{CCA} = 2.5 V$

Product	V <sub>CCI</sub> = 2.5 V	V <sub>CCI</sub> = 3.3 V	V <sub>CCI</sub> = 5 V
A54SX08A	0.8 mA	1.0 mA	2.9 mA
A54SX16A	0.8 mA	1.0 mA	2.9 mA
A54SX32A	0.9 mA	1.0 mA	3.0 mA
A54SX72A	3.6 mA	3.8 mA	4.5 mA

#### Table 2-4 • Supply Voltages

V <sub>CCA</sub>	V <sub>CCI</sub> *	Maximum Input Tolerance	Maximum Output Drive
2. 5 V	2.5 V	5.75 V	2.7 V
2.5 V	3.3 V	5.75 V	3.6 V
2.5 V	5 V	5.75 V	5.25 V

Note: \*3.3 V PCI is not 5 V tolerant due to the clamp diode, but instead is 3.3 V tolerant.

Symbol	Parameter	Condition	Min.	Max.	Units
I <sub>OH(AC)</sub>	Switching Current High	$0 < V_{OUT} \le 1.4^{-1}$	-44	-	mA
		$1.4 \le V_{OUT} < 2.4^{-1, 2}$	(-44 + (V <sub>OUT</sub> - 1.4)/0.024)	_	mA
		3.1 < V <sub>OUT</sub> < V <sub>CCI</sub> <sup>1, 3</sup>	-	EQ 2-1 on page 2-5	-
	(Test Point)	V <sub>OUT</sub> = 3.1 <sup>3</sup>	-	-142	mA
I <sub>OL(AC)</sub>	Switching Current Low	$V_{OUT} \ge 2.2^{-1}$	95	-	mA
		2.2 > V <sub>OUT</sub> > 0.55 <sup>1</sup>	(V <sub>OUT</sub> /0.023)	-	mA
		0.71 > V <sub>OUT</sub> > 0 <sup>1, 3</sup>	-	EQ 2-2 on page 2-5	-
	(Test Point)	V <sub>OUT</sub> = 0.71 <sup>3</sup>	-	206	mA
I <sub>CL</sub>	Low Clamp Current	$-5 < V_{IN} \le -1$	-25 + (V <sub>IN</sub> + 1)/0.015	-	mA
slew <sub>R</sub>	Output Rise Slew Rate	0.4 V to 2.4 V load $^4$	1	5	V/ns
slew <sub>F</sub>	Output Fall Slew Rate	2.4 V to 0.4 V load $^4$	1	5	V/ns

#### Table 2-8 • AC Specifications (5 V PCI Operation)

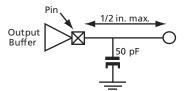
Notes:

1. Refer to the V/I curves in Figure 2-1 on page 2-5. Switching current characteristics for REQ# and GNT# are permitted to be one half of that specified here; i.e., half size output drivers may be used on these signals. This specification does not apply to CLK and RST#, which are system outputs. "Switching Current High" specifications are not relevant to SERR#, INTA#, INTB#, INTC#, and INTD#, which are open drain outputs.

2. Note that this segment of the minimum current curve is drawn from the AC drive point directly to the DC drive point rather than toward the voltage rail (as is done in the pull-down curve). This difference is intended to allow for an optional N-channel pull-up.

3. Maximum current requirements must be met as drivers pull beyond the last step voltage. Equations defining these maximums (A and B) are provided with the respective diagrams in Figure 2-1 on page 2-5. The equation defined maximum should be met by design. In order to facilitate component testing, a maximum current test point is defined for each side of the output driver.

4. This parameter is to be interpreted as the cumulative edge rate across the specified range, rather than the instantaneous rate at any point within the transition range. The specified load (diagram below) is optional; i.e., the designer may elect to meet this parameter with an unloaded output per revision 2.0 of the PCI Local Bus Specification. However, adherence to both maximum and minimum parameters is now required (the maximum is no longer simply a guideline). Since adherence to the maximum slew rate was not required prior to revision 2.1 of the specification, there may be components in the market for some time that have faster edge rates; therefore, motherboard designers must bear in mind that rise and fall times faster than this specification could occur and should ensure that signal integrity modeling accounts for this. Rise slew rate does not apply to open drain outputs.



#### Table 2-14 A545X08A Timing Characteristics (Continued)

(Worst-Case Commercial Conditions,  $V_{CCA} = 2.25 V$ ,  $V_{CCI} = 3.0 V$ ,  $T_J = 70^{\circ}$ C)

		-2 Speed -1 S			-1 Speed		Speed	-F Speed		
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t <sub>INYH</sub>	Input Data Pad to Y High 5 V PCI		0.5		0.6		0.7		0.9	ns
t <sub>INYL</sub>	Input Data Pad to Y Low 5 V PCI		0.8		0.9		1.1		1.5	ns
t <sub>INYH</sub>	Input Data Pad to Y High 5 V TTL		0.5		0.6		0.7		0.9	ns
t <sub>INYL</sub>	Input Data Pad to Y Low 5 V TTL		0.8		0.9		1.1		1.5	ns
Input Modu	le Predicted Routing Delays <sup>2</sup>							-		
t <sub>IRD1</sub>	FO = 1 Routing Delay		0.3		0.3		0.4		0.6	ns
t <sub>IRD2</sub>	FO = 2 Routing Delay		0.5		0.5		0.6		0.8	ns
t <sub>IRD3</sub>	FO = 3 Routing Delay		0.6		0.7		0.8		1.1	ns
t <sub>IRD4</sub>	FO = 4 Routing Delay		0.8		0.9		1		1.4	ns
t <sub>IRD8</sub>	FO = 8 Routing Delay		1.4		1.5		1.8		2.5	ns
t <sub>IRD12</sub>	FO = 12 Routing Delay		2		2.2		2.6		3.6	ns

Notes:

1. For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.

2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

#### Table 2-15 • A54SX08A Timing Characteristics

(Worst-Case Commercial Conditions	V <sub>CCA</sub> = 2.25 V, V <sub>CCI</sub> = 2.25 V, T <sub>J</sub> = 70°C)
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		-2 S	peed	-1 S	peed	Std.	Speed	I –F Speed		
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Dedicated (	Hardwired) Array Clock Networks					1				1
t <sub>HCKH</sub>	Input Low to High (Pad to R-cell Input)		1.4		1.6		1.8		2.6	ns
t <sub>HCKL</sub>	Input High to Low (Pad to R-cell Input)		1.3		1.5		1.7		2.4	ns
t <sub>HPWH</sub>	Minimum Pulse Width High	1.6		1.8		2.1		2.9		ns
t <sub>HPWL</sub>	Minimum Pulse Width Low	1.6		1.8		2.1		2.9		ns
t <sub>HCKSW</sub>	Maximum Skew		0.4		0.4		0.5		0.7	ns
t <sub>HP</sub>	Minimum Period	3.2		3.6		4.2		5.8		ns
f <sub>HMAX</sub>	Maximum Frequency		313		278		238		172	MHz
Routed Arra	y Clock Networks									
t <sub>RCKH</sub>	Input Low to High (Light Load) (Pad to R-cell Input)		1.0		1.1		1.3		1.8	ns
t <sub>RCKL</sub>	Input High to Low (Light Load) (Pad to R-cell Input)		1.1		1.2		1.4		2.0	ns
t <sub>RCKH</sub>	Input Low to High (50% Load) (Pad to R-cell Input)		1.0		1.1		1.3		1.8	ns
t <sub>RCKL</sub>	Input High to Low (50% Load) (Pad to R-cell Input)		1.1		1.2		1.4		2.0	ns
t <sub>RCKH</sub>	Input Low to High (100% Load) (Pad to R-cell Input)		1.1		1.2		1.4		2.0	ns
t <sub>RCKL</sub>	Input High to Low (100% Load) (Pad to R-cell Input)		1.3		1.5		1.7		2.4	ns
t <sub>RPWH</sub>	Minimum Pulse Width High	1.6		1.8		2.1		2.9		ns
t <sub>RPWL</sub>	Minimum Pulse Width Low	1.6		1.8		2.1		2.9		ns
t <sub>RCKSW</sub>	Maximum Skew (Light Load)		0.7		0.8		0.9		1.3	ns
t <sub>RCKSW</sub>	Maximum Skew (50% Load)		0.7		0.8		0.9		1.3	ns
t <sub>RCKSW</sub>	Maximum Skew (100% Load)		0.9		1.0		1.2		1.7	ns

#### Table 2-23 • A54SX16A Timing Characteristics

(Worst-Case Commercial Conditions V <sub>CCA</sub>	= 2.25 V, V <sub>CCI</sub> = 3.0 V, T <sub>J</sub> = 70°C)
--	--

		-3 S	beed*	-2 S	peed	-1 S	peed	Std. Speed		d –F Speed		
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Dedicated	(Hardwired) Array Clock Netwo	rks										<u> </u>
t <sub>НСКН</sub>	Input Low to High (Pad to R-cell Input)		1.2		1.4		1.6		1.8		2.8	ns
t <sub>HCKL</sub>	Input High to Low (Pad to R-cell Input)		1.0		1.1		1.3		1.5		2.2	ns
t <sub>HPWH</sub>	Minimum Pulse Width High	1.4		1.7		1.9		2.2		3.0		ns
t <sub>HPVVL</sub>	Minimum Pulse Width Low	1.4		1.7		1.9		2.2		3.0		ns
t <sub>HCKSW</sub>	Maximum Skew		0.3		0.3		0.4		0.4		0.6	ns
t <sub>HP</sub>	Minimum Period	2.8		3.4		3.8		4.4		6.0		ns
f <sub>HMAX</sub>	Maximum Frequency		357		294		263		227		167	MHz
<b>Routed Arr</b>	ay Clock Networks											
t <sub>RCKH</sub>	Input Low to High (Light Load) (Pad to R-cell Input)		1.0		1.2		1.3		1.5		2.1	ns
t <sub>RCKL</sub>	Input High to Low (Light Load) (Pad to R-cell Input)		1.1		1.3		1.5		1.7		2.4	ns
t <sub>RCKH</sub>	Input Low to High (50% Load) (Pad to R-cell Input)		1.1		1.3		1.4		1.7		2.3	ns
t <sub>RCKL</sub>	Input High to Low (50% Load) (Pad to R-cell Input)		1.1		1.3		1.5		1.7		2.4	ns
t <sub>RCKH</sub>	Input Low to High (100% Load) (Pad to R-cell Input)		1.3		1.5		1.7		2.0		2.7	ns
t <sub>RCKL</sub>	Input High to Low (100% Load) (Pad to R-cell Input)		1.3		1.5		1.7		2.0		2.8	ns
t <sub>RPWH</sub>	Minimum Pulse Width High	1.4		1.7		1.9		2.2		3.0		ns
t <sub>RPWL</sub>	Minimum Pulse Width Low	1.4		1.7		1.9		2.2		3.0		ns
t <sub>RCKSW</sub>	Maximum Skew (Light Load)		0.8		0.9		1.0		1.2		1.7	ns
t <sub>RCKSW</sub>	Maximum Skew (50% Load)		0.8		0.9		1.0		1.2		1.7	ns
t <sub>RCKSW</sub>	Maximum Skew (100% Load)		1.0		1.1		1.3		1.5		2.1	ns

*Note:* \*All –3 speed grades have been discontinued.

#### Table 2-28 A545X32A Timing Characteristics (Continued)

		-3 Sp	beed <sup>1</sup>	-2 Sp	beed	-1 S	peed	Std. 9	Speed	–F Sp	peed	
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t <sub>INYH</sub>	Input Data Pad to Y High 5 V PCI		0.7		0.8		0.9		1.0		1.4	ns
t <sub>INYL</sub>	Input Data Pad to Y Low 5 V PCI		0.9		1.1		1.2		1.4		1.9	ns
t <sub>INYH</sub>	Input Data Pad to Y High 5 V TTL		0.9		1.1		1.2		1.4		1.9	ns
t <sub>INYL</sub>	Input Data Pad to Y Low 5 V TTL		1.4		1.6		1.8		2.1		2.9	ns
Input Modu	le Predicted Routing Delays <sup>3</sup>											
t <sub>IRD1</sub>	FO = 1 Routing Delay		0.3		0.3		0.3		0.4		0.6	ns
t <sub>IRD2</sub>	FO = 2 Routing Delay		0.4		0.5		0.5		0.6		0.8	ns
t <sub>IRD3</sub>	FO = 3 Routing Delay		0.5		0.6		0.7		0.8		1.1	ns
t <sub>IRD4</sub>	FO = 4 Routing Delay		0.7		0.8		0.9		1		1.4	ns
t <sub>IRD8</sub>	FO = 8 Routing Delay		1.2		1.4		1.5		1.8		2.5	ns
t <sub>IRD12</sub>	FO = 12 Routing Delay		1.7		2		2.2		2.6		3.6	ns

#### (Worst-Case Commercial Conditions, $V_{CCA} = 2.25 \text{ V}_{CCI} = 3.0 \text{ V}, T_J = 70^{\circ}\text{C}$ )

Notes:

1. All –3 speed grades have been discontinued.

2. For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.

3. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

#### Table 2-29 A54SX32A Timing Characteristics

(Worst-Case Commercial Condition	<sup>5</sup> V <sub>CCA</sub> = 2.25 V, V <sub>CCI</sub> = 2.25 V, T <sub>J</sub> = 70°C)
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		-3 Speed* -2 Speed		peed	-1 Speed		Std. Speed		-F Speed			
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
Dedicated (	(Hardwired) Array Clock Netwo	rks										<u>.</u>
t <sub>нскн</sub>	Input Low to High (Pad to R-cell Input)		1.7		2.0		2.2		2.6		4.0	ns
t <sub>HCKL</sub>	Input High to Low (Pad to R-cell Input)		1.7		2.0		2.2		2.6		4.0	ns
t <sub>HPWH</sub>	Minimum Pulse Width High	1.4		1.6		1.8		2.1		2.9		ns
t <sub>HPWL</sub>	Minimum Pulse Width Low	1.4		1.6		1.8		2.1		2.9		ns
t <sub>HCKSW</sub>	Maximum Skew		0.6		0.6		0.7		0.8		1.3	ns
t <sub>HP</sub>	Minimum Period	2.8		3.2		3.6		4.2		5.8		ns
f <sub>HMAX</sub>	Maximum Frequency		357		313		278		238		172	MHz
Routed Arra	ay Clock Networks											
t <sub>RCKH</sub>	Input Low to High (Light Load) (Pad to R-cell Input)		2.2		2.5		2.9		3.4		4.7	ns
t <sub>RCKL</sub>	Input High to Low (Light Load) (Pad to R-cell Input)		2.1		2.4		2.7		3.2		4.4	ns
t <sub>RCKH</sub>	Input Low to High (50% Load) (Pad to R-cell Input)		2.4		2.7		3.1		3.6		5.1	ns
t <sub>RCKL</sub>	Input High to Low (50% Load) (Pad to R-cell Input)		2.2		2.5		2.8		3.3		4.6	ns
t <sub>RCKH</sub>	Input Low to High (100% Load) (Pad to R-cell Input)		2.5		2.9		3.2		3.8		5.3	ns
t <sub>RCKL</sub>	Input High to Low (100% Load) (Pad to R-cell Input)		2.4		2.7		3.1		3.6		5.0	ns
t <sub>RPWH</sub>	Minimum Pulse Width High	1.4		1.6		1.8		2.1		2.9		ns
t <sub>RPWL</sub>	Minimum Pulse Width Low	1.4		1.6		1.8		2.1		2.9		ns
t <sub>RCKSW</sub>	Maximum Skew (Light Load)		1.0		1.1		1.3		1.5		2.1	ns
t <sub>RCKSW</sub>	Maximum Skew (50% Load)		0.9		1.0		1.2		1.4		1.9	ns
t <sub>RCKSW</sub>	Maximum Skew (100% Load)		0.9		1.0		1.2		1.4		1.9	ns

*Note:* \*All –3 speed grades have been discontinued.

## Table 2-37 • A54SX72A Timing Characteristics (Continued)

(Worst-Case Commercial Conditions $V_{CCA} = 2.25 \text{ V}$ , $V_{CCI} = 3.0 \text{ V}$ , $T_J = 70^{\circ}\text{C}$ )
---

		-3 Sp	eed*	-2 S	peed	-1 S	peed	Std. 9	Speed	–F S	peed	
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
t <sub>QCKH</sub>	Input Low to High (100% Load) (Pad to R-cell Input)		1.7		1.9		2.2		2.5		3.5	ns
t <sub>QCHKL</sub>	Input High to Low (100% Load) (Pad to R-cell Input)		1.7		2		2.2		2.6		3.6	ns
t <sub>QPWH</sub>	Minimum Pulse Width High	1.5		1.7		2.0		2.3		3.2		ns
t <sub>QPWL</sub>	Minimum Pulse Width Low	1.5		1.7		2.0		2.3		3.2		ns
t <sub>QCKSW</sub>	Maximum Skew (Light Load)		0.2		0.3		0.3		0.3		0.5	ns
t <sub>QCKSW</sub>	Maximum Skew (50% Load)		0.4		0.5		0.5		0.6		0.9	ns
t <sub>QCKSW</sub>	Maximum Skew (100% Load)		0.4		0.5		0.5		0.6		0.9	ns

*Note:* \*All –3 speed grades have been discontinued.

#### Table 2-40 A54SX72A Timing Characteristics

(Worst-Case Commercial	Conditions Vaca -	- 2 25 V V	$30VT_{1} - 70^{\circ}C$
(worst-case commercial	Conditions VCCA -	- 2.23 v, v <sub>CCl</sub> –	3.0 v, 1 = 70 C)

		-3 Sp	beed <sup>1</sup>	-2 S	peed	-1 S	peed	Std.	Speed	d –F Speed		
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
3.3 V PCI O	utput Module Timing <sup>2</sup>											
t <sub>DLH</sub>	Data-to-Pad Low to High		2.3		2.7		3.0		3.6		5.0	ns
t <sub>DHL</sub>	Data-to-Pad High to Low		2.5		2.9		3.2		3.8		5.3	ns
t <sub>ENZL</sub>	Enable-to-Pad, Z to L		1.4		1.7		1.9		2.2		3.1	ns
t <sub>ENZH</sub>	Enable-to-Pad, Z to H		2.3		2.7		3.0		3.6		5.0	ns
t <sub>ENLZ</sub>	Enable-to-Pad, L to Z		2.5		2.8		3.2		3.8		5.3	ns
t <sub>ENHZ</sub>	Enable-to-Pad, H to Z		2.5		2.9		3.2		3.8		5.3	ns
d <sub>TLH</sub> <sup>3</sup>	Delta Low to High		0.025		0.03		0.03		0.04		0.045	ns/pF
d <sub>THL</sub> <sup>3</sup>	Delta High to Low		0.015		0.015		0.015		0.015		0.025	ns/pF
3.3 V LVTTL	Output Module Timing <sup>4</sup>											
t <sub>DLH</sub>	Data-to-Pad Low to High		3.2		3.7		4.2		5.0		6.9	ns
t <sub>DHL</sub>	Data-to-Pad High to Low		3.2		3.7		4.2		4.9		6.9	ns
t <sub>DHLS</sub>	Data-to-Pad High to Low—low slew		10.3		11.9		13.5		15.8		22.2	ns
t <sub>ENZL</sub>	Enable-to-Pad, Z to L		2.2		2.6		2.9		3.4		4.8	ns
t <sub>ENZLS</sub>	Enable-to-Pad, Z to L—low slew		15.8		18.9		21.3		25.4		34.9	ns
t <sub>ENZH</sub>	Enable-to-Pad, Z to H		3.2		3.7		4.2		5.0		6.9	ns
t <sub>ENLZ</sub>	Enable-to-Pad, L to Z		2.9		3.3		3.7		4.4		6.2	ns
t <sub>ENHZ</sub>	Enable-to-Pad, H to Z		3.2		3.7		4.2		4.9		6.9	ns
d <sub>TLH</sub> <sup>3</sup>	Delta Low to High		0.025		0.03		0.03		0.04		0.045	ns/pF
d <sub>THL</sub> <sup>3</sup>	Delta High to Low		0.015		0.015		0.015		0.015		0.025	ns/pF
d <sub>THLS</sub> <sup>3</sup>	Delta High to Low—low slew		0.053		0.053		0.067		0.073		0.107	ns/pF

#### Notes:

1. All –3 speed grades have been discontinued.

2. Delays based on 10 pF loading and 25  $\Omega$  resistance.

3. To obtain the slew rate, substitute the appropriate Delta value, load capacitance, and the  $V_{CCI}$  value into the following equation: Slew Rate [V/ns] =  $(0.1 * V_{CCI} - 0.9 * V_{CCI}) / (C_{load} * d_{T[LH|HL|HLS]})$ where  $C_{load}$  is the load capacitance driven by the I/O in pF

 $d_{T[LH|HL|HLS]}$  is the worst case delta value from the datasheet in ns/pF.

4. Delays based on 35 pF loading.



	100-	TQFP	
Pin Number	A54SX08A Function	A54SX16A Function	A54SX32A Function
71	I/O	I/O	I/O
72	I/O	I/O	I/O
73	I/O	I/O	I/O
74	I/O	I/O	I/O
75	I/O	I/O	I/O
76	I/O	I/O	I/O
77	I/O	I/O	I/O
78	I/O	I/O	I/O
79	I/O	I/O	I/O
80	I/O	I/O	I/O
81	I/O	I/O	I/O
82	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
83	I/O	I/O	I/O
84	I/O	I/O	I/O
85	I/O	I/O	I/O
86	I/O	I/O	I/O
87	CLKA	CLKA	CLKA
88	CLKB	CLKB	CLKB
89	NC	NC	NC
90	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
91	GND	GND	GND
92	PRA, I/O	PRA, I/O	pra, I/o
93	I/O	I/O	I/O
94	I/O	I/O	I/O
95	I/O	I/O	I/O
96	I/O	I/O	I/O
97	I/O	I/O	I/O
98	I/O	I/O	I/O
99	I/O	I/O	I/O
100	TCK, I/O	TCK, I/O	TCK, I/O



329-Pi	n PBGA	329-Pi	n PBGA	329-Pi	n PBGA	329-Pin PBGA		
Pin Number	A54SX32A Function	Pin Number	A54SX32A Function	Pin Number	A54SX32A Function	Pin Number	A54SX32A Function	
A1	GND	AA15	I/O	AC6	I/O	B20	I/O	
A2	GND	AA16	I/O	AC7	I/O	B21	I/O	
A3	V <sub>CCI</sub>	AA17	I/O	AC8	I/O	B22	GND	
A4	NC	AA18	I/O	AC9	V <sub>CCI</sub>	B23	V <sub>CCI</sub>	
A5	I/O	AA19	I/O	AC10	I/O	C1	NC	
A6	I/O	AA20	TDO, I/O	AC11	I/O	C2	TDI, I/O	
A7	V <sub>CCI</sub>	AA21	V <sub>CCI</sub>	AC12	I/O	C3	GND	
A8	NC	AA22	I/O	AC13	I/O	C4	I/O	
A9	I/O	AA23	V <sub>CCI</sub>	AC14	I/O	C5	I/O	
A10	I/O	AB1	I/O	AC15	NC	C6	I/O	
A11	I/O	AB2	GND	AC16	I/O	С7	I/O	
A12	I/O	AB3	I/O	AC17	I/O	С8	I/O	
A13	CLKB	AB4	I/O	AC18	I/O	С9	I/O	
A14	I/O	AB5	I/O	AC19	I/O	C10	I/O	
A15	I/O	AB6	I/O	AC20	I/O	C11	I/O	
A16	I/O	AB7	I/O	AC21	NC	C12	I/O	
A17	I/O	AB8	I/O	AC22	V <sub>CCI</sub>	C13	I/O	
A18	I/O	AB9	I/O	AC23	GND	C14	I/O	
A19	I/O	AB10	I/O	B1	V <sub>CCI</sub>	C15	I/O	
A20	I/O	AB11	PRB, I/O	B2	GND	C16	I/O	
A21	NC	AB12	I/O	B3	I/O	C17	I/O	
A22	V <sub>CCI</sub>	AB13	HCLK	B4	I/O	C18	I/O	
A23	GND	AB14	I/O	B5	I/O	C19	I/O	
AA1	V <sub>CCI</sub>	AB15	I/O	B6	I/O	C20	I/O	
AA2	I/O	AB16	I/O	B7	I/O	C21	V <sub>CCI</sub>	
AA3	GND	AB17	I/O	B8	I/O	C22	GND	
AA4	I/O	AB18	I/O	B9	I/O	C23	NC	
AA5	I/O	AB19	I/O	B10	I/O	D1	I/O	
AA6	I/O	AB20	I/O	B11	I/O	D2	I/O	
AA7	I/O	AB21	I/O	B12	PRA, I/O	D3	I/O	
AA8	I/O	AB22	GND	B13	CLKA	D4	TCK, I/O	
AA9	I/O	AB23	I/O	B14	I/O	D5	I/O	
AA10	I/O	AC1	GND	B15	I/O	D6	I/O	
AA11	I/O	AC2	V <sub>CCI</sub>	B16	I/O	D7	I/O	
AA12	I/O	AC3	NC	B17	I/O	D8	I/O	
AA13	I/O	AC4	I/O	B18	I/O	D9	I/O	
AA14	I/O	AC5	I/O	B19	I/O	D10	I/O	

		484-Pin FBG	
Nu	A54SX72A Function	A54SX32A Function	Pin Number
	I/O	I/O	C19
	V <sub>CCI</sub>	V <sub>CCI</sub>	C20
	I/O	I/O	C21
	I/O	I/O	C22
	I/O	I/O	C23
	I/O	I/O	C24
	I/O	NC*	C25
	I/O	NC*	C26
	I/O	NC*	D1
	TMS	TMS	D2
	I/O	I/O	D3
	V <sub>CCI</sub>	V <sub>CCI</sub>	D4
	I/O	NC*	D5
	TCK, I/O	TCK, I/O	D6
	I/O	I/O	D7
	I/O	I/O	D8
	I/O	I/O	D9
	I/O	I/O	D10
	I/O	I/O	D11
	QCLKC	I/O	D12
	I/O	I/O	D13
	I/O	I/O	D14
	I/O	I/O	D15
	I/O	I/O	D16
	I/O	I/O	D17
	I/O	I/O	D18
	I/O	I/O	D19
	I/O	I/O	D20
	V <sub>CCI</sub>	V <sub>CCI</sub>	D21
	GND	GND	D22
	I/O	I/O	D23
	I/O	I/O	D24
	I/O	NC*	D25
	I/O	NC*	D26
	I/O	NC*	E1

484-Pin FBGA							
Pin Number	A54SX32A Function	A54SX72A Function					
E2	NC*	I/O					
E3	I/O	I/O					
E4	I/O	I/O					
E5	GND	GND					
E6	TDI, IO	TDI, IO					
E7	I/O	I/O					
E8	I/O	I/O					
E9	I/O	I/O					
E10	I/O	I/O					
E11	I/O	I/O					
E12	I/O	I/O					
E13	V <sub>CCA</sub>	V <sub>CCA</sub>					
E14	CLKB	CLKB					
E15	I/O	I/O					
E16	I/O	I/O					
E17	I/O	I/O					
E18	I/O	I/O					
E19	I/O	I/O					
E20	I/O	I/O					
E21	I/O	I/O					
E22	I/O	I/O					
E23	I/O	I/O					
E24	I/O	I/O					
E25	V <sub>CCI</sub>	V <sub>CCI</sub>					
E26	GND	GND					
F1	V <sub>CCI</sub>	V <sub>CCI</sub>					
F2	NC*	I/O					
F3	NC*	I/O					
F4	I/O	I/O					
F5	I/O	I/O					
F22	I/O	I/O					
F23	I/O	I/O					
F24	I/O	I/O					
F25	I/O	I/O					
F26	NC*	I/O					

484-Pin FBGA							
Pin Number	A54SX32A Function	A54SX72A Function					
G1	NC*	I/O					
G2	NC*	I/O					
G3	NC*	I/O					
G4	I/O	I/O					
G5	I/O	I/O					
G22	I/O	I/O					
G23	V <sub>CCA</sub>	V <sub>CCA</sub>					
G24	I/O	I/O					
G25	NC*	I/O					
G26	NC*	I/O					
H1	NC*	I/O					
H2	NC*	I/O					
H3	I/O	I/O					
H4	I/O	I/O					
H5	I/O	I/O					
H22	I/O	I/O					
H23	I/O	I/O					
H24	I/O	I/O					
H25	NC*	I/O					
H26	NC*	I/O					
J1	NC*	I/O					
J2	NC*	I/O					
J3	I/O	I/O					
J4	I/O	I/O					
J5	I/O	I/O					
J22	I/O	I/O					
J23	I/O	I/O					
J24	I/O	I/O					
J25	V <sub>CCI</sub>	V <sub>CCI</sub>					
J26	NC*	I/O					
K1	I/O	I/O					
K2	V <sub>CCI</sub>	V <sub>CCI</sub>					
К3	I/O	I/O					
К4	I/O	I/O					
K5	V <sub>CCA</sub>	V <sub>CCA</sub>					

**Actel**°

**SX-A Family FPGAs** 

*Note:* \*These pins must be left floating on the A54SX32A device.



# **Datasheet Information**

# List of Changes

The following table lists critical changes that were made in the current version of the document.

Previous Version	Changes in Current Version (v5.3)	Page
v5.2	-3 speed grades have been discontinued.	N/A
(June 2006)	The "SX-A Timing Model" was updated with –2 data.	2-14
v5.1	RoHS information was added to the "Ordering Information".	ii
February 2005	The "Programming" section was updated.	1-13
v5.0	Revised Table 1 and the timing data to reflect the phase out of the $-3$ speed grade for the A54SX08A device.	i
	The "Thermal Characteristics" section was updated.	2-11
	The "176-Pin TQFP" was updated to add pins 81 to 90.	3-11
	The "484-Pin FBGA" was updated to add pins R4 to Y26	3-26
v4.0	The "Temperature Grade Offering" is new.	1-iii
	The "Speed Grade and Temperature Grade Matrix" is new.	1-iii
	"SX-A Family Architecture" was updated.	1-1
	"Clock Resources" was updated.	1-5
	"User Security" was updated.	1-7
	"Power-Up/Down and Hot Swapping" was updated.	1-7
	"Dedicated Mode" is new	1-9
	Table 1-5 is new.	1-9
	"JTAG Instructions" is new	1-10
	"Design Considerations" was updated.	1-12
	The "Programming" section is new.	1-13
	"Design Environment" was updated.	1-13
	"Pin Description" was updated.	1-15
	Table 2-1 was updated.	2-1
	Table 2-2 was updated.	2-1
	Table 2-3 is new.	2-1
	Table 2-4 is new.	2-1
	Table 2-5 was updated.	2-2
	Table 2-6 was updated.	2-2
	"Power Dissipation" is new.	2-8
	Table 2-11 was updated.	2-9



# **Datasheet Categories**

In order to provide the latest information to designers, some datasheets are published before data has been fully characterized. Datasheets are designated as "Product Brief," "Advanced," "Production," and "Datasheet Supplement." The definitions of these categories are as follows:

## **Product Brief**

The product brief is a summarized version of a datasheet (advanced or production) containing general product information. This brief gives an overview of specific device and family information.

## Advanced

This datasheet version contains initial estimated information based on simulation, other products, devices, or speed grades. This information can be used as estimates, but not for production.

## Unmarked (production)

This datasheet version contains information that is considered to be final.

## **Datasheet Supplement**

The datasheet supplement gives specific device information for a derivative family that differs from the general family datasheet. The supplement is to be used in conjunction with the datasheet to obtain more detailed information and for specifications that do not differ between the two families.

# International Traffic in Arms Regulations (ITAR) and Export Administration Regulations (EAR)

The products described in this datasheet are subject to the International Traffic in Arms Regulations (ITAR) or the Export Administration Regulations (EAR). They may require an approved export license prior to their export. An export can include a release or disclosure to a foreign national inside or outside the United States.